IEEE STD 1149.1 (JTAG) TAP MASTERS WITH 16-BIT GENERIC HOST INTERFACES

SCAS190E - JUNE 1990 - REVISED JANUARY 1997

- **Members of the Texas Instruments SCOPE™** Family of Testability Products
- Compatible With the IEEE Standard 1149.1-1990 (JTAG) Test Access Port and **Boundary-Scan Architecture**
- **Control Operation of Up to Six Parallel Target Scan Paths**
- Accommodate Pipeline Delay to Target of **Up to 31 Clock Cycles**
- Scan Data Up to 232 Clock Cycles

- Execute Instructions for Up to 2³² Clock Cycles
- Each Device Includes Four Bidirectional **Event Pins for Additional Test Capability**
- Inputs Are TTL-Voltage Compatible
- **EPIC™** (Enhanced-Performance Implanted CMOS) 1-µm Process
- Packaged in 44-Pin Plastic Leaded Chip Carrier (FN), 68-Pin Ceramic Pin Grid Array (GB), and 68-Pin Ceramic Quad Flat Packages (HV)

description

The 'ACT8990 test-bus controllers (TBC) are members of the Texas Instruments SCOPE™ testability integrated-circuit family. This family of components supports IEEE Standard 1149.1-1990 (JTAG) boundary scan to facilitate testing of complex circuit-board assemblies. The 'ACT8990 differ from other SCOPE™ integrated circuits. Their function is to control the JTAG serial-test bus rather than being target boundary-scannable devices.

The required signals of the JTAG serial-test bus – test clock (TCK), test mode select (TMS), test data input (TDI), and test data output (TDO) can be connected from the TBC to a target device without additional logic. This is done as a chain of IEEE Standard 1149.1-1990 boundary-scannable components that share the same serial-test bus. The TBC generates TMS and TDI signals for its target(s), receives TDO signals from its target(s), and buffers its test clock input (TCKI) to a test clock output (TCKO) for distribution to its target(s). The TMS, TDI, and TDO signals can be connected to a target directly or via a pipeline, with a retiming delay of up to 31 bits. Since the TBC can be configured to generate up to six separate TMS signals [TMS (5-0)], it can be used to control up to six target scan paths that are connected in parallel (i.e., sharing common TCK, TDI, and TDO signals).

While most operations of the TBC are synchronous to TCKI, a test-off (TOFF) input is provided for output control of the target interface, and a test-reset (TRST) input is provided for hardware/software reset of the TBC. In addition, four event [EVENT (3-0)] I/Os are provided for asynchronous communication to target device(s). Each event has its own event generation/detection logic, and detected events can be counted by two 16-bit counters.

The TBC operates under the control of a host microprocessor/microcontroller via the 5-bit address bus [ADRS (4-0)] and the 16-bit read/write data bus [DATA (15-0)]. Read (\overline{RD}) and write (\overline{WR}) strobes are implemented such that the critical host-interface timing is independent of the TCKI period. Any one of 24 registers can be addressed for read and/or write operations. In addition to control and status registers, the TBC contains two command registers, a read buffer, and a write buffer. Status of the TBC is transmitted to the host via ready (\overline{RDY}) and interrupt (\overline{INT}) outputs.

Major commands can be issued by the host to cause the TBC to generate the TMS sequences necessary to move the target(s) from any stable test-access-port (TAP) controller state to any other stable TAP state, to execute instructions in the Run-Test/Idle TAP state, or to scan instruction or test data through the target(s). A 32-bit counter can be preset to allow a predetermined number of execution or scan operations.

Serial data that appears at the selected TDI input (TDI1 or TDI0) is transferred into the read buffer, which can be read by the host to obtain up to 16 bits of the serial-data stream. Serial data that is transmitted from the TDO output is written by the host to the write buffer.



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description (continued)

The SN54ACT8990 is characterized for operation over the full military temperature range of –55°C to 125°C. The SN74ACT8990 is characterized for operation from 0°C to 70°C.

SN54ACT8990 . . . HV PACKAGE (TOP VIEW) ADRS2 ADRS1 NC ADRS0 ADRS3 NC ADRS4 GND IN N 8 8 8 7 6 5 4 3 2 1 68 67 66 65 64 63 62 61 NC 1 10 NC 'éо П DATA0 1 11 59 F TMS5/EVENT3 DATA1 12 TMS4/EVENT2 58 NC 🛮 13 NC 57 DATA2 1 14 TMS3/EVENT1 56 DATA3 1 15 TMS2/EVENT0 55 NC 1 16 NC 54 🛮 DATA4 🛮 17 V_{CC} 53 **П** GND 18 52 ∏GND V_{CC} 19 51 **∏** TMS1 NC 20 50 ∏NC DATA5 21 49 **☐** TMS0 DATA6 🛮 22 48 **∏**TDO NC 23 47 ∏NC DATA7 24 46 **∏** TCKO DATA8 25 45 **∏**TCKI NC 26 44 NC 27 28 29 30 31 32 33 34 35 36 37 38 39 40 41 42 43

VCC DATA14

DATA13

2

DATA15 TOFF

SC

TDIO

2

NC - No internal connection

DATA10

2

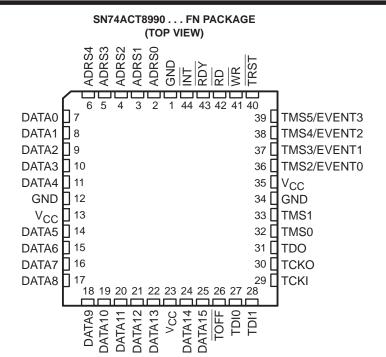
DATA9

DATA11 DATA12



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SN54ACT8990 . . . GB PACKAGE (TOP VIEW)

	1	2	3	4	5	6	7	8	9	10	11
Α		0	0	0	0	0	0	0	0	0	
В	0	\odot	0	0	0	0	0	0	0	0	0
С	0	\odot	\odot							0	0
D	0	\odot								0	0
Е	0	\odot								0	0
F	0	\odot								0	0
G	0	\odot								0	0
н	0	\odot								0	0
J	0	\odot								\odot	0
κ	0	\odot	\odot	\odot	0	0	0	0	\odot	0	0
L		0	0	0	0	0	0	0	0	0	



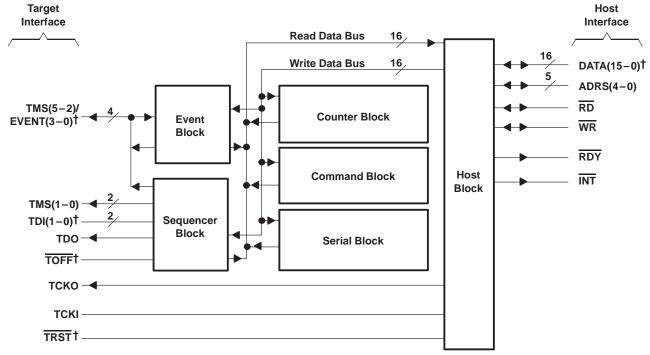
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Table 1. Terminal Assignments

Т	TERMINAL		TERMINAL		TERMINAL		TERMINAL	
NO.	NAME	NO.	NAME	NO.	NAME	NO.	NAME	
A2	NC	B10	NC	F11	NC	K6	NC	
A3	ADRS4	B11	NC	G1	DATA5	K7	VCC	
A4	NC	C1	DATA2	G2	NC	K8	DATA15	
A5	ADRS1	C2	DATA1	G10	NC	K9	TDI0	
A6	ADRS0	C3	NC	G11	TMS1	K10	NC	
A7	NC	C10	TMS4/EVENT2	H1	NC	K11	TCKI	
A8	ĪNT	C11	TMS5/EVENT3	H2	DATA6	L2	DATA9	
A9	RD	D1	DATA4	H10	TDO	L3	NC	
A10	TRST	D2	DATA3	H11	TMS0	L4	DATA12	
B1	DATA0	D10	TMS3/EVENT1	J1	DATA8	L5	DATA13	
B2	NC	D11	NC	J2	DATA7	L6	NC	
В3	ADRS3	E1	NC	J10	TCKO	L7	DATA14	
B4	ADRS2	E2	GND	J11	NC	L8	TOFF	
B5	NC	E10	Vcc	K1	NC	L9	TDI1	
В6	NC	E11	TMS2/EVENT0	K2	NC	L10	NC	
В7	GND	F1	Vcc	K3	DATA10		·	
B8	RDY	F2	NC	K4	DATA11		·	
B9	WR	F10	GND	K5	NC		·	

NC - No internal connection

functional block diagram



[†] Inputs have internal pullup resistors.



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Terminal Functions

TERMINAL NAME	I/O	DESCRIPTION
ADRS4-ADRS0	I	Address inputs. ADRS4 – ADRS0 form the 5-bit address bus that interfaces the TBC to its host. These inputs specify the TBC register to be read from or written to.
DATA15-DATA0	I/O	Data inputs and outputs. DATA15 – DATA0 form the 16-bit bidirectional data bus that interfaces the TBC to its host. Data is read from or written to the TBC register using this data bus.
GND		Ground
ĪNT	0	Interrupt. INT transmits an interrupt signal to the host. When the TBC requires service from the host, INT is asserted (low). INT will remain asserted (low) until the host has completed the required service.
NC		No connection
RD	I	Read strobe. \overline{RD} is the active low output enable for the data bus. \overline{RD} is used as the strobe for reading data from the selected TBC register.
RDY	0	Ready. $\overline{\text{RDY}}$ transmits a status signal to the host. When the TBC is ready to accept a read or write operation from the host, $\overline{\text{RDY}}$ is asserted (low). $\overline{\text{RDY}}$ is not asserted (high) when the TBC is in recovery from a read, write, command, or reset operation.
тскі	I	Test clock input. TCKI is the clock input for the TBC. Most operations of the TBC are synchronous to TCKI. When enabled, all target interface outputs change on the falling edge of TCKI. Sampling of target interface inputs are configured to occur on either the rising edge or falling edge of TCKI.
тско	0	Test clock output. TCKO distributes TCK to the target(s). The TCKO is configured to be disabled, constant zero, constant one, or to follow TCKI. When TCKO follows TCKI, it is delayed to match the delay of generating the TDO and TMS signals.
TDI1-TDI0	I	Test data inputs. The TDI1-TDI0 serial inputs are used for shifting test data from the target(s). The TDI inputs can be directly connected to the TDO pin(s) of the target(s).
TDO	0	Test data output. TDO is used for shifting test data into the target(s). TDO can be directly connected to the TDI terminal(s) of the target(s).
TMS1-TMS0	0	Test mode select outputs. These parallel outputs transmit TMS signals to the target(s), which direct them through their TAP controller states. TMS1-TMS0 can be directly connected to the TMS terminals of the target(s).
TMS5-TMS2/ EVENT3-EVENT0	I/O	Test mode select outputs or event inputs/outputs. These I/Os can be configured for use as either TMS outputs or event inputs/outputs. As TMS outputs, they function similarly to TMS1-TMS0 above. As event I/Os, they can be used to receive/transmit interrupt signals to/from the target(s).
TOFF	I	Test-off input. TOFF is the active low output disable for all outputs and I/Os of the target interface (TCKO, TDO, TMS, TMS/EVENT).
TRST	I	Test-reset input. TRST is used to initiate hardware and software reset operations of the TBC. Hardware reset begins when TRST is asserted (low). Software reset begins when TRST is released (high) and proceeds synchronously to TCKI to completion in a predetermined number of cycles.
WR	I	Write input. WR is the strobe for writing data to a TBC data register. Signals present at the data and address buses are captured on the rising edge of WR.
VCC		Supply voltage

SN54ACT8990, SN74ACT8990 **TEST-BUS CONTROLLERS**

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage range, V _{CC}	0.5 V to 7 V
Input voltage range, V _I (see Note 1)	0.5 V to V _{CC}
Output voltage range, V _O (see Note 1)	0.5 V to V _{CC}
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)	±20 mÅ
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$)	±20 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	±25 mA
Maximum power dissipation at T _A = 55°C (in still air) (see Note 2): FN package	1.5W
Storage temperature range, T _{stq}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
 - 2. The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 75 mils. For more information, refer to the Package Thermal Considerations application note in the ABT Advanced BiCMOS Technology Data Book, literature number SCBD002.

recommended operating conditions

		SN54ACT8990		SN74A	UNIT	
		MIN	MAX	MIN	MAX	ONII
VCC	Supply voltage	4.5	5.5	4.5	5.5	V
V_{IH}	High-level input voltage	2		2		V
V _{IL}	Low-level input voltage		0.8		0.8	V
٧ı	Input voltage	0	Vcc	0	VCC	V
Vo	Output voltage	0	Vcc	0	VCC	V
IOH	High-level output current		-8		-8	mA
loL	Low-level output current		8		8	mA
TA	Operating free-air temperature	-55	125	0	70	°C



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T _A = 25°C			SN54ACT8990		SN74ACT8990		UNIT
	PARAMETER	1231 0	CONDITIONS	MIN	TYP†	MAX	MIN	MAX	MIN	MAX	UNIT
		V _{CC} = 4.5 V	I _{OH} = -20 μA	4.4			4.4		4.4		
VOH		VCC = 4.5 V	$I_{OH} = -8 \text{ mA}$	3.7			3.7		3.7		. ,
VOH		V _{CC} = 5.5 V	I _{OH} = -20 μA	5.4			5.4		5.4]
		VCC = 5.5 V	$I_{OH} = -8 \text{ mA}$	4.7			4.7		4.7		
VOL		V _{CC} = 4.5 V	I _{OL} = 20 μA			0.1		0.1		0.1	V
VOL	_	to 5.5 V	I _{OL} = 8 mA			0.5		0.5		0.5	V
	ADRS, RD, WR, TCKI	$V_{CC} = 5.5 \text{ V},$	$V_{I} = V_{CC}$ or GND			±1		±1		±1	
l _l	TDI, TOFF,	V _{CC} = 5.5 V	$V_I = V_{CC}$			±1		±1		±1	μΑ
	TRST		vCC = 5.5 v	$V_I = GND$	-35	-70	-250	-35	-250	-35	-250
	INT, RDY, TCKO, TDO, TMS	V _{CC} = 5.5 V,	$V_O = V_{CC}$ or GND			±10		±10		±10	
loz‡	DATA,	V00 - 5 5 V	VO = VCC			±10		±10		±10	μΑ
	TMS/EVENT	V _{CC} = 5.5 V	V _O = GND	-35	-70	-250	-35	-250	-35	-250	
,		$V_{CC} = 5.5 \text{ V},$ $I_{O} = 0,$	V _I = V _{CC} or GND			450*		450		450	μА
Icc		$V_{CC} = 5.5 \text{ V},$	C _L = 50 pF		100						mA
		f _{clock} = 30 MHz	Z								IIIA
Ci		$V_I = V_{CC}$ or GI	ND ON		5*						pF
Cio		$V_I = V_{CC}$ or GI	ND		9*						pF
Co		V _I = V _{CC} or GI	ND		8*						pF

^{*} On products compliant to MIL-PRF-38535, this parameter does not apply. † Typical values are at V_{CC} = 5 V.

[‡] For I/O ports, the parameter IOZ includes the input leakage.

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timing requirements over recommended ranges of supply voltage and operating free-air temperature (see Figure 1)

			SN54A	CT8990	SN74A	CT8990			
			MIN	MAX	MIN	MAX	UNIT		
fclock	Clock frequency		0	30	0	30	MHz		
		RD low [†]			5.5		ns		
		WR low	5.5		5.5				
t _W	Pulse duration	EVENT high or low	8		8]		
		TCKI high or low	10.5		10.5		ns		
		TRST low	6		6		1		
		ADRS [†] before RD↑			6.5		ns		
		ADRS before WR↑	6.5		6.5				
		DATA before WR↑	6		6				
t _{su}	Setup time	EVENT before TCKI↑	6		5.5				
		EVENT before TCKI↓	5		5		ns		
		TDI before TCKI↑	2		2				
		TDI before TCKI↓	2		2		1		
		ADRS [†] after RD↑			5		ns		
		ADRS after WR↑	5.5		5				
		DATA after WR↑	5.5		5.5]		
th	Hold time	EVENT after TCKI↑	5.5		5]		
		EVENT after TCKI↓	5		5		ns		
		TDI after TCKI↑	4		2.5				
		TDI after TCKI↓	4		2.5		1		

[†] Applies only in the case where ADRS (4-0) = 10110 (read buffer).



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switching characteristics over recommended ranges of supply voltage and operating free-air temperature (see Figure 1)

DADAMETED	METER FROM TO	SN54A	CT8990	90 SN74ACT8990				
PARAMETER	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	UNIT	
f _{max}			30		30		MHz	
^t PLH	ADRS	DATA	8	43	19.5	39.3	ns	
^t PHL		DATA	8	43	19.5	39.3	115	
t=	RD↑	RDY	5.3	17	5.3	13.8	ns	
^t PLH	WR↑	RDY	2.5	16	2.5	13	115	
^t PLH	TCKI↑	ĪNT	3.7	16	3.7	12.9	ns	
^t PHL	ICKII	IIN I	5.5	15	5.5	13.1	115	
^t PHL	TCKI↑	RDY	4.4	15	4.4	13.4	ns	
^t PLH	TCKI↑	TCKO	3.3	17	3.3	14.1	ns	
^t PLH	тскі↓	TCKO	2.3	19	2.3	15.9		
^t PHL	ICNI↓	ТСКО	3.6	17	3.6	15.6	ns	
tPLH	TCKI↓	TDO	2.9	19	2.9	17.5		
t _{PHL}	ICNI↓	100	5.2	20	5.2	17.9	ns	
^t PLH	TCKI↓	TMC	3.1	19	3.1	17.5	ns	
^t PHL	ICKI↓	TMS	5.1	19	5.1	18.2		
tPLH	TOKI	TAAO/EN/EAIT	1.5	19	1.5	17.5	ns	
^t PHL	TCKI↓	TMS/EVENT	3.5	20	3.5	18.9		
^t PZH	==:	DATA	3.8	21	3.8	17.6	ns	
^t PZL	RD↓	DATA	6.8	28	6.8	22.6		
	— - · · · · A	INT	4.9	19	4.9	15.3	1	
^t PZH	TCKI↑	RDY	3.6	19	3.6	15.3	ns	
^t PZH	TCKI↓	TOVO	4.1	23	4.1	19.2		
tPZL	ICKI↓	ТСКО	4.8	20	4.8	17.4	ns	
^t PZH	TCKI↓	TDO	4.3	22	4.3	19.5		
t _{PZL}	ICNI↓	TDO	5	20	5	17.7	ns	
^t PZH	TCKI↓	TMC	4.6	23	4.6	19.9		
tPZL	ICKI↓	TMS	5.1	20	5.1	18.5	ns	
^t PZH	TOVI	TMC/EV/ENIT	2	21	2	18.8		
^t PZL	TCKI↓	TMS/EVENT	3.2	20	3.2	18.7	ns	
^t PZH		TOVO	4.6	16	4.6	12.2		
tPZL	TOFF↑	ТСКО	3.1	14	3.1	10.3	ns	
^t PZH		TDO	4.4	15	4.4	12.2		
^t PZL	TOFF↑	TDO	3.5	14	3.5	10.8	ns	
^t PZH		TMC	3.1	16.2	3.1	14.7		
^t PZL	IOFF	TMS	1.9	16.7	1.9	13.6	ns	



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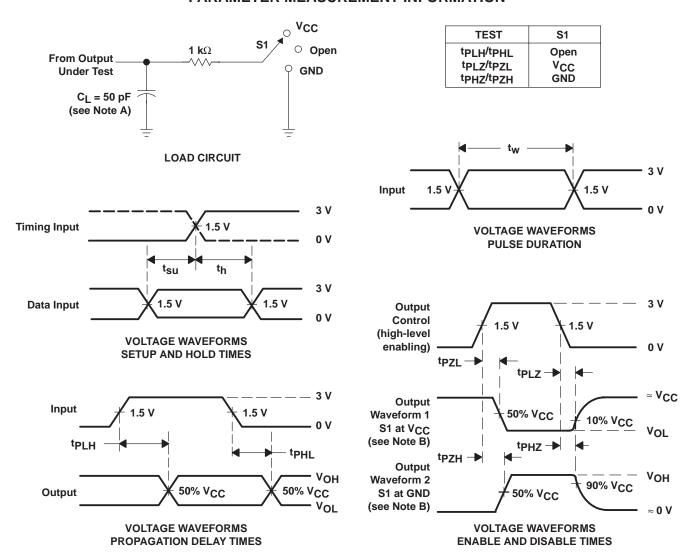
switching characteristics over recommended ranges of supply voltage and operating free-air temperature (continued) (see Figure 1)

DADAMETED	FROM	то	SN54ACT8990	SN74ACT8990	UNIT
PARAMETER	(INPUT)	(OUTPUT)	MIN MAX	MIN MAX	וואט
^t PZH		TMC/EV/ENIT	2.3 15.3	2.3 13.8	
t _{PZL}		TMS/EVENT	2.7 16.4	2.7 13.9	ns
^t PHZ		DATA	3.8 18.4	3.8 15.4	
^t PLZ	RD↑	DATA	4.1 17.1	4.1 14.8	ns
^t PHZ	тскі↓	TCKO	6.7 20.4	6.7 19.8	
^t PLZ	ICNI↓	ТСКО	4.8 21.1	4.8 20.4	ns
^t PHZ	тскі↓	TDO	5.1 21.7	5.1 21.3	
^t PLZ	TONI↓	100	5 20.7	5 20.3	ns
^t PHZ	тскі↓	TMS	6.9 22.4	6.9 21.9	
^t PLZ	TONI↓	TIVIS	4.6 20.6	4.6 20.1	ns
^t PHZ	тскі↓	TMS/EVENT	4.7 22.5	4.7 22.1	ns
^t PLZ	TONI↓	TIVIS/EVEIVI	2.8 20.5	2.8 20.1	
^t PHZ	TOFF↓	тско	5 15.6	5 15.4	ns
^t PLZ	IOFF↓	TCKO	4.4 15.5	4.4 15.3	
^t PHZ	TOFF↓	TDO	5.6 16.6	5.6 16.5	ns
^t PLZ	IOFF↓	100	4.6 15.4	4.6 15.4	
^t PHZ	TOFF↓	TMS	4.8 19.1	4.8 17.1	ns
t _{PLZ}	IOFF↓	TIVIS	4.4 17	4.4 15.8	
^t PHZ	TOFF↓	TMS/EVENT	4.5 18.8	4.5 17.3	
tPLZ	TOFF↓	TIVIS/EVEIVI	2.4 17.1	2.4 16.2	ns
^t PHZ	TRST↓	DATA	5.7 23	5.7 20.8	ns
^t PLZ	IKSI↓	DAIA	4.2 20.3	4.2 20	115
^t PHZ	TRST↓	ĪNT	6 19.6	8 19.5	ns
^t PLZ	IKSI↓	IIN I	6.1 18	6.1 17.8	115
^t PHZ	TRST↓	RDY	6.5 18.8	6.5 18.7	ne
^t PLZ	IK9I↓	אטז	4.8 17.8	4.8 17.8	ns
^t PHZ	TRST↓	TMS/EVENT	6 21.1	6 21.1	ns
^t PLZ] IK31↓	I IVIO/E V EIN I	4.2 20	4.2 19.9	



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PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50 \Omega$, $t_f \leq 3$ ns, $t_f \leq 3$ ns. For testing pulse duration: $t_r = t_f = 1$ to 3 ns. Pulse polarity can be either high-to-low-to-high or low-to-high-to-low.
- D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms





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PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
5962-9322801MXA	ACTIVE	CFP	HV	68	1	TBD	Call TI	Level-NC-NC-NC
5962-9322801MYA	ACTIVE	CPGA	GB	68	1	TBD	Call TI	Level-NC-NC-NC
SN74ACT8990FN	ACTIVE	PLCC	FN	44	26	TBD	Call TI	Level-3-220C-168 HR
SN74ACT8990FNR	ACTIVE	PLCC	FN	44	500	TBD	Call TI	Level-3-220C-168 HR
SNJ54ACT8990GB	ACTIVE	CPGA	GB	68	1	TBD	Call TI	Level-NC-NC-NC
SNJ54ACT8990HV	ACTIVE	CFP	HV	68	1	TBD	Call TI	Level-NC-NC-NC

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS) or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

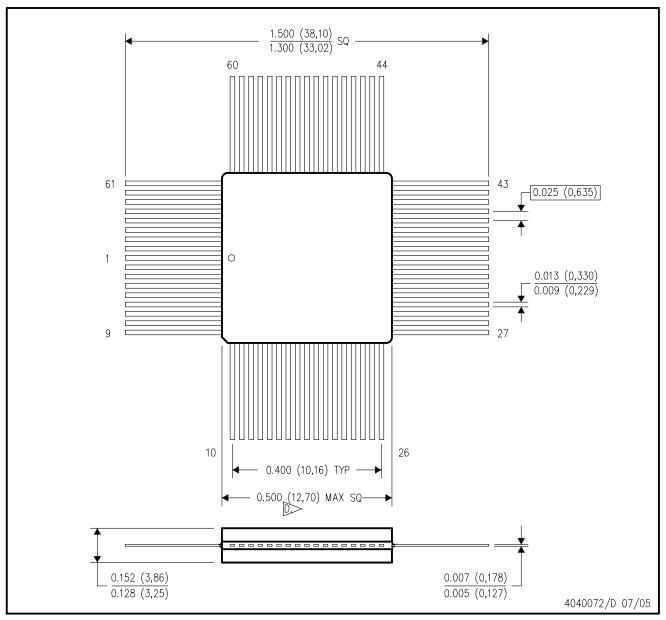
(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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HV (S-GQFP-F68)

CERAMIC QUAD FLATPACK



NOTES:

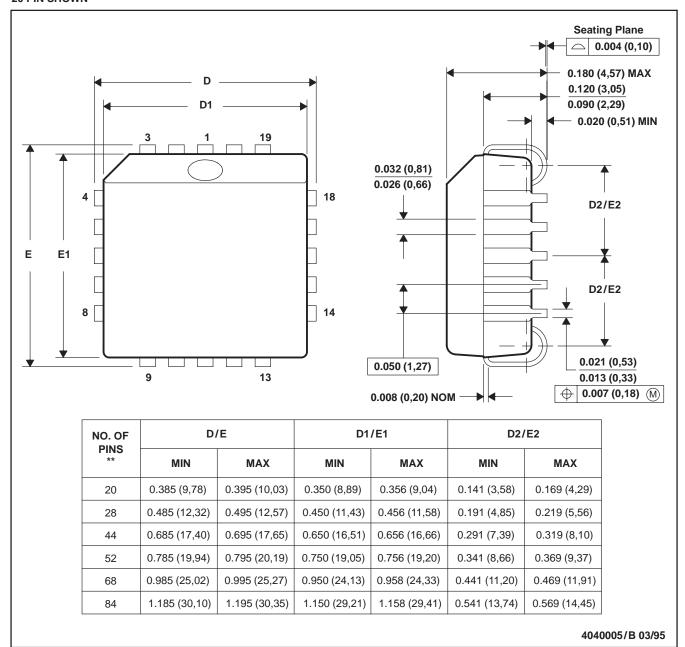
- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- This dimension allows for package edge anomalies caused by material protrusion, such as rough ceramic, misaligned ceramic layers and lids, meniscus, and glass overrun.



FN (S-PQCC-J**)

20 PIN SHOWN

PLASTIC J-LEADED CHIP CARRIER



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Falls within JEDEC MS-018

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